

CD54HC173, CD74HC173, CD54HCT173

Data sheet acquired from Harris Semiconductor SCHS158E

February 1998 - Revised October 2003

High-Speed CMOS Logic Quad D-Type Flip-Flop, Three-State

Features

- Three-State Buffered Outputs
- Gated Input and Output Enables
- Fanout (Over Temperature Range)
 - Standard Outputs............... 10 LSTTL Loads
 - Bus Driver Outputs 15 LSTTL Loads
- Wide Operating Temperature Range . . . -55°C to 125°C
- Balanced Propagation Delay and Transition Times
- Significant Power Reduction Compared to LSTTL Logic ICs
- HC Types
 - 2V to 6V Operation
 - High Noise Immunity: N_{IL} = 30%, N_{IH} = 30% of V_{CC} at V_{CC} = 5V
- HCT Types
 - 4.5V to 5.5V Operation
 - Direct LSTTL Input Logic Compatibility, V_{IL}= 0.8V (Max), V_{IH} = 2V (Min)
 - CMOS Input Compatibility, I_I \leq 1 μ A at V_{OL}, V_{OH}

Description

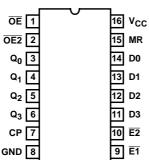
The 'HC173 and 'HCT173 high speed three-state quad D-type flip-flops are fabricated with silicon gate CMOS technology. They possess the low power consumption of standard CMOS Integrated circuits, and can operate at speeds comparable to the equivalent low power Schottky devices. The buffered outputs can drive 15 LSTTL loads. The large output drive capability and three-state feature make these parts ideally suited for interfacing with bus lines in bus oriented systems

The four D-type flip-flops operate synchronously from a common clock. The outputs are in the three-state mode when either of the two output disable pins are at the logic "1" level. The input ENABLES allow the flip-flops to remain in their present states without having to disrupt the clock If either of the 2 input ENABLES are taken to a logic "1" level, the Q outputs are fed back to the inputs, forcing the flip-flops to remain in the same state. Reset is enabled by taking the MASTER RESET (MR) input to a logic "1" level. The data outputs change state on the positive going edge of the clock.

The 'HCT173 logic family is functionally, as well as pin compatible with the standard LS logic family.

Pinout

CD54HC173, CD54HCT173 (CERDIP) CD74HC173 (PDIP, SOIC, SOP, TSSOP) CD74HCT173 (PDIP, SOIC) TOP VIEW

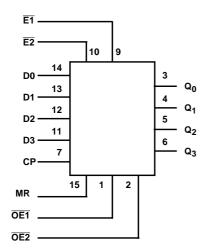


Ordering Information

PART NUMBER	TEMP. RANGE (°C)	PACKAGE
CD54HC173F3A	-55 to 125	16 Ld CERDIP
CD54HCT173F3A	-55 to 125	16 Ld CERDIP
CD74HC173E	-55 to 125	16 Ld PDIP
CD74HC173M	-55 to 125	16 Ld SOIC
CD74HC173MT	-55 to 125	16 Ld SOIC
CD74HC173M96	-55 to 125	16 Ld SOIC
CD74HC173NSR	-55 to 125	16 Ld SOP
CD74HC173PW	-55 to 125	16 Ld TSSOP
CD74HC173PWR	-55 to 125	16 Ld TSSOP
CD74HC173PWT	-55 to 125	16 Ld TSSOP
CD74HCT173E	-55 to 125	16 Ld PDIP
CD74HCT173M	-55 to 125	16 Ld SOIC
CD74HCT173MT	-55 to 125	16 Ld SOIC
CD74HCT173M96	-55 to 125	16 Ld SOIC

NOTE: When ordering, use the entire part number. The suffixes 96 and R denote tape and reel. The suffix T denotes a small-quantity reel of 250.

Functional Diagram



TRUTH TABLE

	INP				
		DATA E	NABLE	DATA	OUTPUT
MR	СР	E1	E2	D	Qn
Н	Х	Х	Х	Х	L
L	L	Х	Х	Х	Q_0
L	1	Н	X	Х	Q_0
L	1	Х	H	Х	Q ₀
L	↑	L	1	L	L
L	↑	L	L	Н	Н

H= High Voltage Level

L = Low Voltage Level

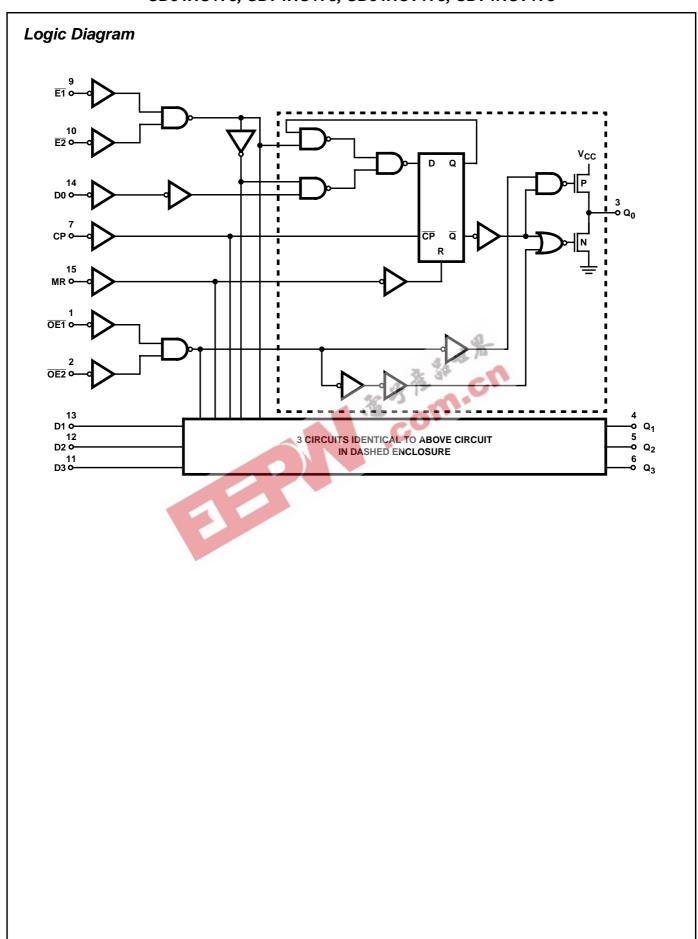
X= Irrelevant

 \uparrow = Transition from Low to High Level

 $\mathbf{Q}_0\mathbf{=}$ Level Before the Indicated Steady-State Input Conditions Were Established

NOTE:

When either OE1 or OE2 (or both) is (are) high, the output is disabled to the high-impedance state, however, sequential operation of the flip-flops is not affected.



Absolute Maximum Ratings DC Supply Voltage, V_{CC} -0.5V to 7V DC Input Diode Current, I_{IK}

Thermal Information

Package Thermal Impedance, θ _{JA} (see Note 2):
E (PDIP) Package
M (SOIC) Package73°C/W
NS (SOP) Package
PW (TSSOP) Package 108°C/W
Maximum Junction Temperature
Maximum Storage Temperature Range65°C to 150°C
Maximum Lead Temperature (Soldering 10s)300°C
(SOIC - Lead Tips Only)

Operating Conditions

Temperature Range (T _A)55°C	to 125°C
Supply Voltage Range, V _{CC}	
HC Types	2V to 6V
HCT Types	√ to 5.5V
DC Input or Output Voltage, V _I , V _O 0	V to V _{CC}
Input Rise and Fall Time	
2V	ns (Max)
4.5V 500	ns (Max)
6V	ns (Max)

CAUTION: Stresses above those listed in "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress only rating and operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied.

The package thermal impedance is calculated in accordance with JESD 51-7.

DC Electrical Specifications

DC Electrical Specifications

			ST TIONS			25°C		-40°C T	O 85°C	-55°C T	O 125 ⁰ C	
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES												
High Level Input	VIH	1		2	1.5	-	-	1.5	-	1.5	-	V
Voltage				4.5	3.15	-	-	3.15	-	3.15	-	V
				6	4.2	-	-	4.2	-	4.2	-	V
Low Level Input Voltage	V _{IL}	-	-	2	-	-	0.5	-	0.5	-	0.5	V
voltage				4.5	-	-	1.35	-	1.35	-	1.35	V
				6	-	-	1.8	-	1.8	-	1.8	V
High Level Output	V _{OH}	V _{IH} or	-0.02	2	1.9	-	-	1.9	-	1.9	-	V
Voltage CMOS Loads		V _{IL}	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
			-0.02	6	5.9	-	-	5.9	-	5.9	-	V
High Level Output			-6	4.5	3.98	-	-	3.84	-	3.7	-	V
Voltage TTL Loads			-7.8	6	5.48	-	-	5.34	-	5.2	-	٧
Low Level Output	V _{OL}	V _{IH} or	0.02	2	-	-	0.1	-	0.1	-	0.1	٧
Voltage CMOS Loads		V _{IL}	0.02	4.5	-	1	0.1	i	0.1	-	0.1	V
			0.02	6	ı	ı	0.1	i	0.1	-	0.1	V
Low Level Output			6	4.5	ı	ı	0.26	i	0.33	-	0.4	V
Voltage TTL Loads			7.8	6	-	-	0.26	-	0.33	-	0.4	V
Input Leakage Current	ΙΙ	V _{CC} or GND	-	6	-	-	±0.1	-	±1	-	±1	μА
Quiescent Device Current	I _{CC}	V _{CC} or GND	0	6	-	-	8	=	80	-	160	μΑ

DC Electrical Specifications (Continued)

			ST			25°C		-40°C T	O 85°C	-55°C T	O 125°C	
PARAMETER	SYMBOL	V _I (V)	I _O (mA)	V _{CC} (V)	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNITS
Three-State Leakage Current	l _{OZ}	V _{IL} or V _{IH}	-	6	-	-	±0.5	-	±0.5	-	±10	μΑ
HCT TYPES	•	-	•	•				-		•		
High Level Input Voltage	V _{IH}	-	-	4.5 to 5.5	2	-	-	2	-	2	-	V
Low Level Input Voltage	V _{IL}	-	-	4.5 to 5.5	-	-	0.8	-	0.8	-	0.8	V
High Level Output Voltage CMOS Loads	V _{OH}	V _{IH} or V _{IL}	-0.02	4.5	4.4	-	-	4.4	-	4.4	-	V
High Level Output Voltage TTL Loads			-6	4.5	3.98	-	-	3.84	-	3.7	-	V
Low Level Output Voltage CMOS Loads	V _{OL}	V _{IH} or V _{IL}	0.02	4.5	-	-	0.1	水水	0.1	-	0.1	V
Low Level Output Voltage TTL Loads			6	4.5	100	多	0.26	J.C	0.33	-	0.4	V
Input Leakage Current	lı	V _{CC} to GND	0	5.5	-	C	±0.1	-	±1	-	±1	μА
Quiescent Device Current	Icc	V _{CC} or GND	0	5.5		_	8	-	80	-	160	μА
Additional Quiescent Device Current Per Input Pin: 1 Unit Load	ΔI _{CC} (Note 3)	V _{CC} -2.1		4.5 to 5.5	1	100	360	-	450	-	490	μА
Three-State Leakage Current	loz	V _{IL} or V _{IH}	-	5.5	-	-	±0.5	-	±5.0	-	±10	μА

NOTE:

HCT Input Loading Table

INPUT	UNIT LOADS
D0-D3	0.15
E1 and E2	0.15
СР	0.25
MR	0.2
OE1 and OE2	0.5

NOTE: Unit Load is ΔI_{CC} limit specified in DC Electrical Specifications table, e.g., 360 μ A max at 25 o C.

^{3.} For dual-supply systems theoretical worst case (V_I = 2.4V, V_{CC} = 5.5V) specification is 1.8mA.

Switching Specifications Input t_{r} , $t_{f} = 6 \text{ns}$

		TEST		25	°C	-40°C TO 85°C	-55°C TO 125°C		
PARAMETER	SYMBOL	CONDITIONS	V _{CC} (V)	TYP	MAX	MAX	MAX	UNITS	
HC TYPES					•				
Propagation Delay, Clock to	t _{PLH} , t _{PHL}	C _L = 50pF	2	-	200	250	300	ns	
Output			4.5	-	40	50	60	ns	
		C _L = 15pF	5	17	-	-	-	ns	
		CL = 50pF	6	-	34	43	51	ns	
Propagation Delay, MR to	t _{PHL}	C _L = 50pF	2	-	175	220	265	ns	
Output			4.5	-	35	44	53	ns	
		C _L = 15pF	5	12	-	-	-	ns	
		CL = 50pF	6	-	30	37	45	ns	
Propagation Delay Output	t _{PLZ} , t _{PHZ}	CL = 50pF	2		150	190	225	ns	
Enable to Q (Figure 6)	t _{PZL} , t _{PZH}	C _L = 50pF	4.5		30	38	45	ns	
		C _L = 15pF	5	12	-	-	-	ns	
		CL = 50pF	6		26	33	38	ns	
Output Transition Times	t _{TLH} , t _{THL}	C _L = 50pF	2	-	60	75	90	ns	
			4.5	- 3	12	15	18	ns	
			6	3C -33	10	13	15	ns	
Maximum Clock Frequency	f _{MAX}	C _L = 15pF	5	60	9/11	-	-	MHz	
Input Capacitance	C _{IN}			-	10	10	10	pF	
Three-State Output Capacitance	СО			-	10	10	10	pF	
Power Dissipation Capacitance (Notes 4, 5)	C _{PD}		5	29	-	-	-	pF	
HCT TYPES					•			•	
Propagation Delay, Clock to	t _{PLH} , t _{PHL}	C _L = 50pF	4.5	-	40	50	60	ns	
Output		C _L = 15pF	5	17	-	-	-	ns	
Propagation Delay, MR to	t _{PHL}	C _L = 50pF	4.5	-	44	55	66	ns	
Output		C _L = 15pF	5	18	-	-	-	ns	
Propagation Delay Output	t _{PZL} , t _{PZH}	CL = 50pF	2		150	190	225	ns	
Enable to Q (Figure 6)		C _L = 50pF	4.5		30	38	45	ns	
		C _L = 15pF	5	14	-	-	-	ns	
		CL = 50pF	6		26	33	38	ns	
Output Transition Times	t _{TLH} , t _{THL}	C _L = 50pF	4.5	-	15	19	22	ns	
Maximum Clock Frequency	f _{MAX}	C _L = 15pF	5	60	-	-	-	MHz	
Input Capacitance	C _{IN}	-	-	-	10	10	10	pF	
Power Dissipation Capacitance (Notes 4, 5)	C _{PD}	-	5	34	-	-	-	pF	

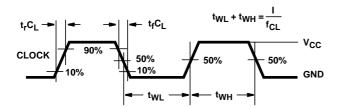
^{4.} $C_{\mbox{PD}}$ is used to determine the dynamic power consumption, per package.

^{5.} $P_D = V_{CC}^2 f_i + \sum (C_L V_{CC}^2 + f_O)$ where $f_i = Input$ Frequency, $f_O = Input$ Frequency, $C_L = Output$ Load Capacitance, $V_{CC} = Supply$ Voltage.

Prerequisite For Switching Specifications

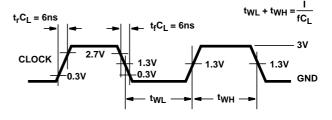
			25	°C	-40°C T	O 85°C	-55°C T	O 125°C	
PARAMETER	SYMBOL	V _{CC} (V)	MIN	MAX	MIN	MAX	MIN	MAX	UNITS
HC TYPES	<u> </u>	•					•		•
Maximum Clock Frequency	f _{MAX}	2	6	-	5	-	4	-	MHz
		4.5	30	-	24	-	20	-	MHz
		6	35	-	28	-	24	-	MHz
MR Pulse Width	t _w	2	80	=	100	-	120	-	ns
		4.5	16	=	20	-	24	-	ns
		6	14	=	17	-	20	-	ns
Clock Pulse Width	t _w	2	80	=	100	-	120	-	ns
		4.5	16	=	20	-	24	-	ns
		6	14	=	17	-	20	-	ns
Set-up Time, Data to Clock	t _{SU}	2	60	=	75	8	90	-	ns
and $\overline{\overline{E}}$ to Clock		4.5	12	- 4	15	-0	18	-	ns
		6	10	537	13	O •	15	-	ns
Hold Time, Data to Clock	t _H	2	3	3	3	-	3	-	ns
		4.5	3	10	3	-	3	-	ns
		6	3	-	3	-	3	-	ns
Hold Time, E to Clock	tн	2	0	-	0	-	0	-	ns
		4.5	0	-	0	-	0	-	ns
		6	0	-	0	-	0	-	ns
Removal Time, MR to Clock	t _{REM}	2	60	-	75	-	90	-	ns
		4.5	12	-	15	-	18	-	ns
		6	10	-	13	-	15	-	ns
HCT TYPES	•					•			
Maximum Clock Frequency	f _{MAX}	4.5	20	-	16	-	13	-	MHz
MR Pulse Width	t _w	4.5	15	-	19	-	22	-	ns
Clock Pulse Width	t _w	4.5	25	-	31	-	38	-	ns
Set-up Time,	t _{SU}	4.5	12	-	15	-	18	-	ns
Set-up Time, Data to Clock	tsu	4.5	18	-	23	-	27	-	ns
Hold Time, Data to Clock	t _H	4.5	0	-	0	-	0	-	ns
Hold Time, $\overline{\mathbb{E}}$ to Clock	t _H	4.5	0	-	0	-	0	-	ns
Removal Time, MR to Clock	t _{REM}	4.5	12	-	15	-	18	-	ns

Test Circuits and Waveforms



NOTE: Outputs should be switching from 10% V_{CC} to 90% V_{CC} in accordance with device truth table. For f_{MAX} , input duty cycle = 50%.

FIGURE 1. HC CLOCK PULSE RISE AND FALL TIMES AND PULSE WIDTH



NOTE: Outputs should be switching from 10% V_{CC} to 90% V_{CC} in accordance with device truth table. For f_{MAX} , input duty cycle = 50%.

FIGURE 2. HCT CLOCK PULSE RISE AND FALL TIMES AND PULSE WIDTH

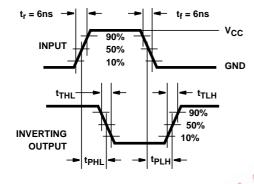


FIGURE 3. HC AND HCU TRANSITION TIMES AND PROPAGA-TION DELAY TIMES, COMBINATION LOGIC

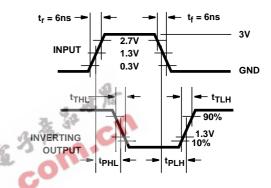


FIGURE 4. HCT TRANSITION TIMES AND PROPAGATION DELAY TIMES, COMBINATION LOGIC

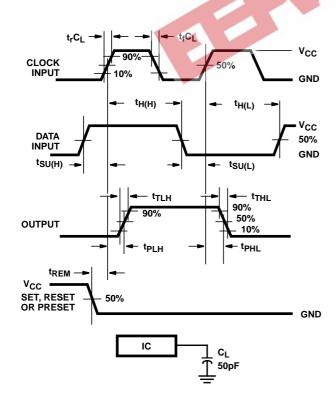


FIGURE 5. HC SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS

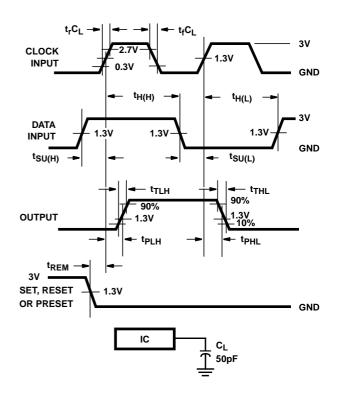


FIGURE 6. HCT SETUP TIMES, HOLD TIMES, REMOVAL TIME, AND PROPAGATION DELAY TIMES FOR EDGE TRIGGERED SEQUENTIAL LOGIC CIRCUITS

Test Circuits and Waveforms (Continued) t_f -3V OUTPUT v_{cc} OUTPUT DISABLE **DISABLE** 50% 0.3 10% GND GND t_{PZL} t_{PZL} t_{PLZ} → t_{PLZ} → **OUTPUT LOW OUTPUT LOW** 50% TO OFF TO OFF 1.3V 10% 10% ◆ t_{PHZ} ◆ ← t_{PZH} ← t_{PHZ} ← <- t_{PZH} → 90% 90% **OUTPUT HIGH OUTPUT HIGH** TO OFF TO OFF OUTPUTS -OUTPUTS OUTPUTS OUTPUTS **OUTPUTS OUTPUTS ENABLED** ENABLED DISABLED **ENABLED** DISABLED ENABLED FIGURE 7. HC THREE-STATE PROPAGATION DELAY FIGURE 8. HCT THREE-STATE PROPAGATION DELAY **WAVEFORM WAVEFORM** OTHER (OUTPUT INPUTS IC WITH $R_L = 1k\Omega$ V_{CC} FOR t_{PLZ} AND t_{PZL} TIED HIGH THREE-

NOTE: Open drain waveforms t_{PLZ} and t_{PZL} are the same as those for three-state shown on the left. The test circuit is Output $R_L = 1k\Omega$ to V_{CC} , $C_L = 50pF$.

 $\textbf{C}_{\textbf{L}}$

50pF

OR LOW 0

OUTPUT DISABLE STATE

OUTPUT

GND FOR tPHZ AND tPZH

FIGURE 9. HC AND HCT THREE-STATE PROPAGATION DELAY TEST CIRCUIT





www.ti.com 28-Feb-2005

PACKAGING INFORMATION

Orderable Device	Status ⁽¹⁾	Package Type	Package Drawing	Pins	Package Qty	Eco Plan ⁽²⁾	Lead/Ball Finish	MSL Peak Temp ⁽³⁾
5962-8682501EA	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
5962-8875901EA	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD54HC173F	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD54HC173F3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD54HCT173F3A	ACTIVE	CDIP	J	16	1	None	Call TI	Level-NC-NC-NC
CD74HC173E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD74HC173M	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD74HC173M96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD74HC173MT	ACTIVE	SOIC	D	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD74HC173NSR	ACTIVE	SO	NS	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD74HC173PW	ACTIVE	TSSOP	PW	16	90	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD74HC173PWR	ACTIVE	TSSOP	PW	16	2000	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD74HC173PWT	ACTIVE	TSSOP	PW	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-1-250C-UNLIM
CD74HCT173E	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	Level-NC-NC-NC
CD74HCT173M	ACTIVE	SOIC	D	16	40	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD74HCT173M96	ACTIVE	SOIC	D	16	2500	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM
CD74HCT173MT	ACTIVE	SOIC	D	16	250	Pb-Free (RoHS)	CU NIPDAU	Level-2-260C-1 YEAR/ Level-1-235C-UNLIM

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

None: Not yet available Lead (Pb-Free).

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Green (RoHS & no Sb/Br): TI defines "Green" to mean "Pb-Free" and in addition, uses package materials that do not contain halogens, including bromine (Br) or antimony (Sb) above 0.1% of total product weight.

(3) MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDECindustry standard classifications, and peak solder temperature.

Important Information and Disclaimer: The information provided on this page represents TI's knowledge and belief as of the date that it is provided. TI bases its knowledge and belief on information provided by third parties, and makes no representation or warranty as to the

⁽²⁾ Eco Plan - May not be currently available - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.



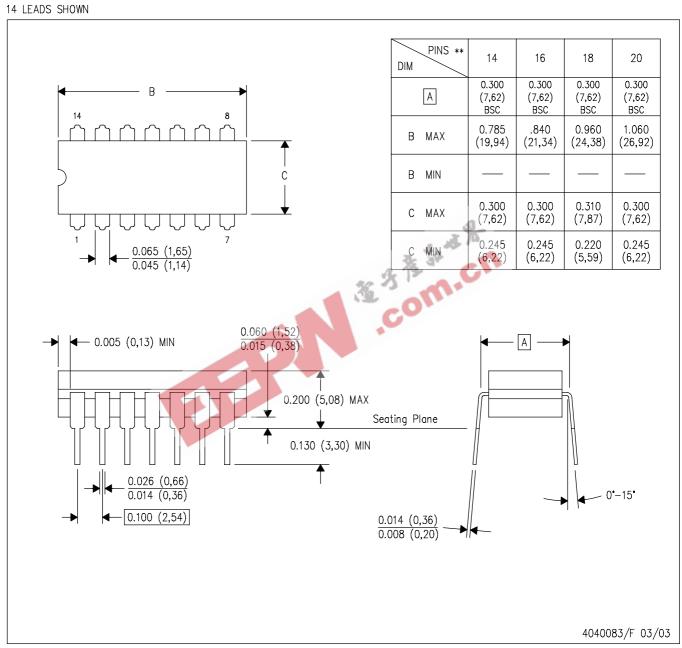
PACKAGE OPTION ADDENDUM

28-Feb-2005

accuracy of such information. Efforts are underway to better integrate information from third parties. TI has taken and continues to take reasonable steps to provide representative and accurate information but may not have conducted destructive testing or chemical analysis on incoming materials and chemicals. TI and TI suppliers consider certain information to be proprietary, and thus CAS numbers and other limited information may not be available for release.

In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.



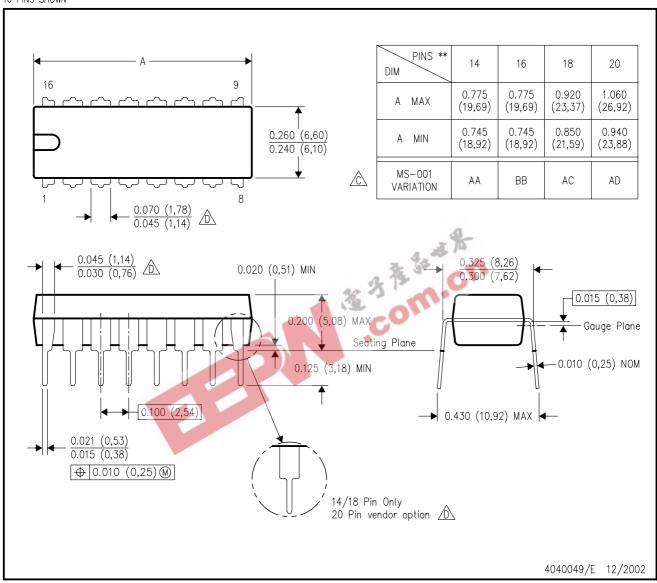


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN

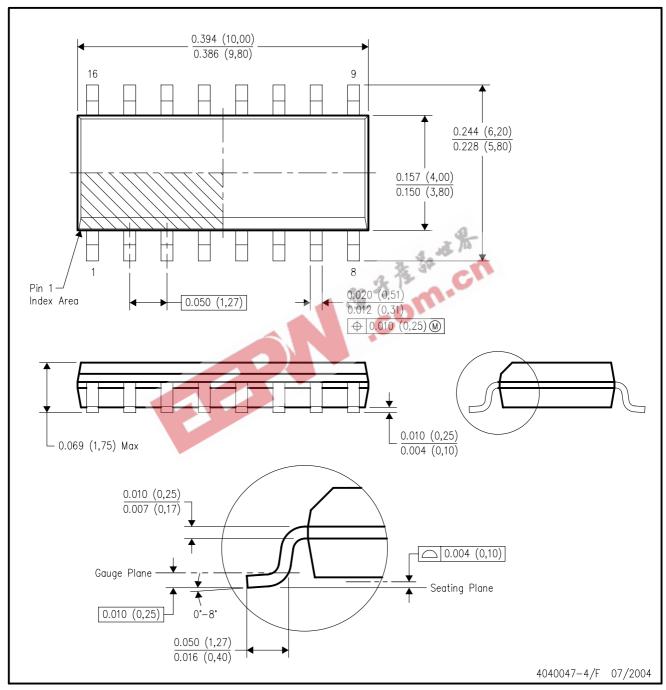


- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.



D (R-PDSO-G16)

PLASTIC SMALL-OUTLINE PACKAGE



- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion not to exceed 0.006 (0,15).
- D. Falls within JEDEC MS-012 variation AC.

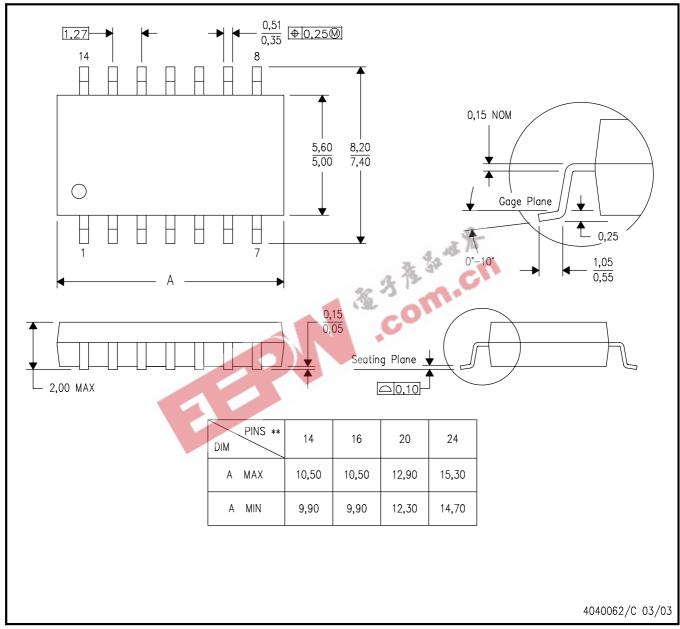


MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



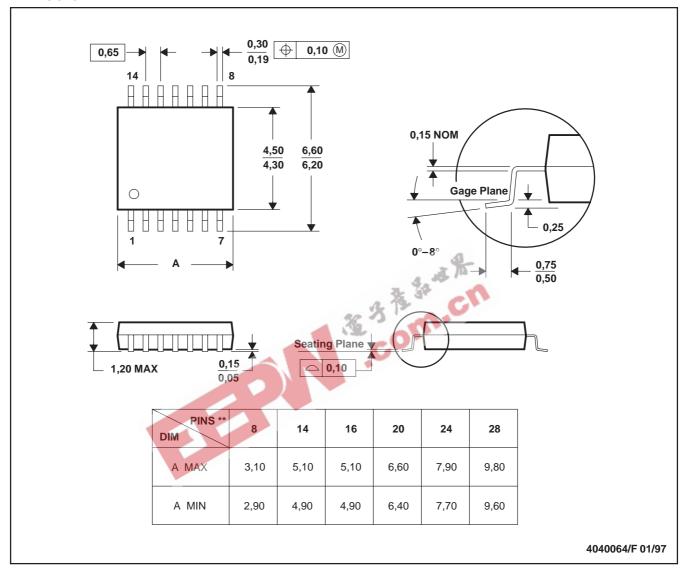
- A. All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



PW (R-PDSO-G**)

PLASTIC SMALL-OUTLINE PACKAGE

14 PINS SHOWN



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion not to exceed 0,15.

D. Falls within JEDEC MO-153

IMPORTANT NOTICE

Texas Instruments Incorporated and its subsidiaries (TI) reserve the right to make corrections, modifications, enhancements, improvements, and other changes to its products and services at any time and to discontinue any product or service without notice. Customers should obtain the latest relevant information before placing orders and should verify that such information is current and complete. All products are sold subject to TI's terms and conditions of sale supplied at the time of order acknowledgment.

TI warrants performance of its hardware products to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are used to the extent TI deems necessary to support this warranty. Except where mandated by government requirements, testing of all parameters of each product is not necessarily performed.

TI assumes no liability for applications assistance or customer product design. Customers are responsible for their products and applications using TI components. To minimize the risks associated with customer products and applications, customers should provide adequate design and operating safeguards.

TI does not warrant or represent that any license, either express or implied, is granted under any TI patent right, copyright, mask work right, or other TI intellectual property right relating to any combination, machine, or process in which TI products or services are used. Information published by TI regarding third-party products or services does not constitute a license from TI to use such products or services or a warranty or endorsement thereof. Use of such information may require a license from a third party under the patents or other intellectual property of the third party, or a license from TI under the patents or other intellectual property of TI.

Reproduction of information in TI data books or data sheets is permissible only if reproduction is without alteration and is accompanied by all associated warranties, conditions, limitations, and notices. Reproduction of this information with alteration is an unfair and deceptive business practice. TI is not responsible or liable for such altered documentation.

Resale of TI products or services with statements different from or beyond the parameters stated by TI for that product or service voids all express and any implied warranties for the associated TI product or service and is an unfair and deceptive business practice. TI is not responsible or liable for any such statements.

Following are URLs where you can obtain information on other Texas Instruments products and application solutions:

Products		Applications	
Amplifiers	amplifier.ti.com	Audio	www.ti.com/audio
Data Converters	dataconverter.ti.com	Automotive	www.ti.com/automotive
DSP	dsp.ti.com	Broadband	www.ti.com/broadband
Interface	interface.ti.com	Digital Control	www.ti.com/digitalcontrol
Logic	logic.ti.com	Military	www.ti.com/military
Power Mgmt	power.ti.com	Optical Networking	www.ti.com/opticalnetwork
Microcontrollers	microcontroller.ti.com	Security	www.ti.com/security
		Telephony	www.ti.com/telephony
		Video & Imaging	www.ti.com/video
		Wireless	www.ti.com/wireless

Mailing Address: Texas Instruments

Post Office Box 655303 Dallas, Texas 75265

Copyright © 2005, Texas Instruments Incorporated